

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10630438	TSURUOKA, TAKAO
	<b>Examiner</b>	<b>Art Unit</b>
	Henn, Timothy J	2622

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
348	241,243,245,246	2/17/07	TJH
382	254,260,270-273	2/17/07	TJH

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Consulted QEM Re: Variance and Temperature	2/17/07	TJH
Consulted Yogesh Aggarwal Re: Thresholds	2/17/07	TJH
Updated Search	4/10/08	TJH
Updated Search	5/10/09	TJH

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
	USPGPUB Text Search	5/10/09	TJH

	/Timothy J Henn/ Primary Examiner, Art Unit 2622
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